

30V N-Channel Trench MOSFET(Preliminary)

General Description

- Trench Power technology
- Low R_{DS(ON)}
- Low Gate Charge
- Optimized for fast-switching applications

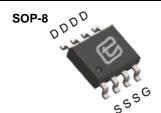
Applications

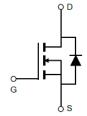
- Synchronous Rectification in DC/DC and AC/DC Converters
- Isolated DC/DC Converters in Telecom and Industrial

Product Summary

 $\begin{array}{ll} V_{DS} & 30V \\ I_D \ (at \ V_{GS} \!=\! 10V) & 15A \\ \\ R_{DS(ON)} \ (at \ V_{GS} \!=\! 10V) & <8m\Omega \\ \\ R_{DS(ON)} \ (at \ V_{GS} \!=\! 4.5V) & <10m\Omega \end{array}$







Part Number	Package Type	Form	Marking	
TTJ15N03AT	SOP-8	Tape & Reel	TTJ15N03AT	

Absolute Maximum Ratings (T_A =25°C unless otherwise noted)

Parameter		Symbol	Maximum	Units
Drain-Source Voltage		V _{DS}	30	V
Gate-Source Voltage		V _{GS}	±20	V
Continuous Drain Current B	T _C =25°C	I _D	15	Δ
Continuous Drain Current B	T _C =70°C		12	А
Pulsed Drain Current A		I _{DM}	45	Α
Avalanche Current A		I _{AS}	23	А
Single Pulse Avalanche Energy L =0.3mH ^A		E _{AS}	79	mJ
Power Dissipation ^C	T _C =25°C	Б	3.4	W
rowei Dissipation	T _C =70°C	P _D	2.1	W
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 150	°C

Thermal Characteristics

Parameter		Symbol	Maximum	Units	
Maximum Junction-to-Lead	Steady-State	R_{\ThetaJL}	22	00.444	
Maximum Junction-to-Ambient	Steady-State	$R_{\Theta JA}$	100	°C/W	



Electric	cal Characteristics(T _J =25°C ur	nless otherwise i	noted)				
Currele el	Donomotor	Conditions		Value			11.2
Symbol	Parameter			Min	Тур	Max	Units
STATIC P	ARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =250μA,V _{GS} =0V		30			V
	Zero Gate Voltage Drain Current	V _{DS} =30V, V _{GS} =0V	T _J =25°C			1	μА
I _{DSS}			T _J =125°C			100	
I _{GSS}	Gate-Body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 20V$	_			±100	nA
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$		1	1.4	2	V
		V _{GS} =10V, I _D =15A			6.7	8	mΩ
R _{DS(ON)}	Static Drain-Source On-Resistance				8.3	10	mΩ
g _{FS}	Forward Transconductance	V _{DS} =5V, I _D =15A			21		S
V _{SD}	Diode Forward Voltage	I _S =15A, V _{GS} =0V				1	V
I _S	Maximum Body-Diode Continuous Curre	nt ^B				15	Α
DYNAMIC	PARAMETERS					Į.	
C _{iss}	Input Capacitance	$V_{GS} = 0V$, $V_{DS} = 15V$, $f = 1MH_Z$ $f = 1MH_Z$			1592		pF
C _{oss}	Output Capacitance				229		
C _{rss}	Reverse Transfer Capacitance				183		
R_g	Gate Resistance				1.5		Ω
SWITCHIN	NG PARAMETERS				•		
Q _g (10V)	Total Gate Charge				29		
Q _g (4.5V)	Total Gate Charge	10)/// 15)//	1		15		nC
Q_{gs}	Gate Source Charge	$V_{GS} = 10V, V_{DS} = 15V, I_{D} = 15A$			3.8		
Q_{gd}	Gate Drain Charge				7		
t _{D(on)}	Turn-On Delay Time	$V_{GS} = 10V, V_{DS} = 15V, I_{D} = 15A,$ $R_{G} = 1.8\Omega$			33.3		
t _r	Turn-On Rise Time				3.3		ns
$T_{D(off)}$	Turn-Off Delay Time				56.6		
t _f	Turn-Off Fall Time				3.5		
t _{rr}	Body Diode Reverse Recovery Time	1 -200 4:/44 400 5 /			38		ns
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =20A, di/dt =100A/μs			16.6		nC

- A. Single pulse width limited by maximum junction temperature.
- B. The maximum current rating is package limited.
- C. The power dissipation P_D is based on $T_{J(MAX)}$ =150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

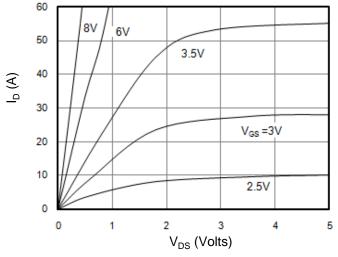


Figure 1: On-Region Characteristics

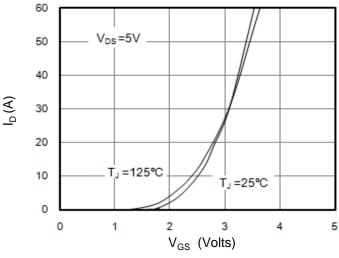


Figure 2: Transfer Characteristics

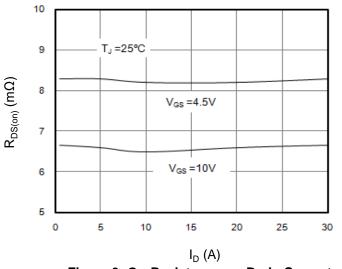


Figure 3: On-Resistance vs. Drain Current

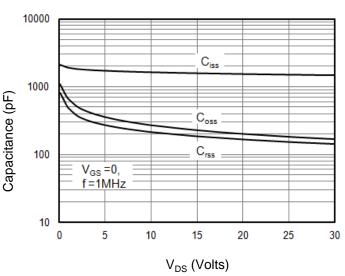


Figure 4: Capacitance Characteristics

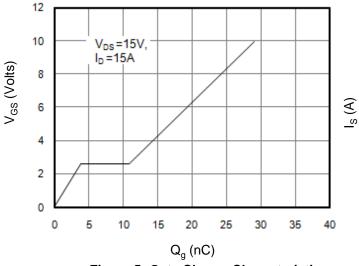


Figure 5: Gate Charge Characteristics

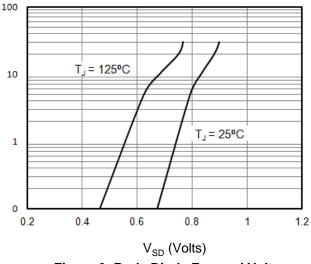


Figure 6: Body Diode Forward Voltage



 $Z_{\,\theta\, JC}$ Normalized Transient Thermal Resistance

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

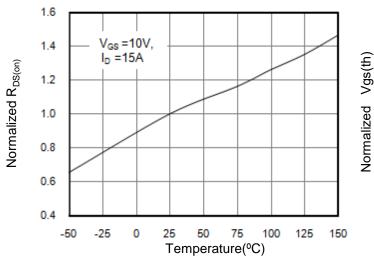


Figure 7: On-Resistance vs. Junction Temperature

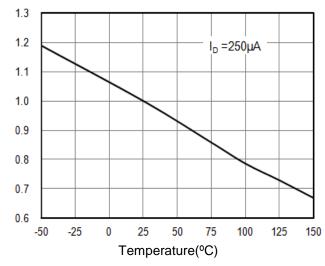


Figure 8: Vgs(th) vs. Junction Temperature

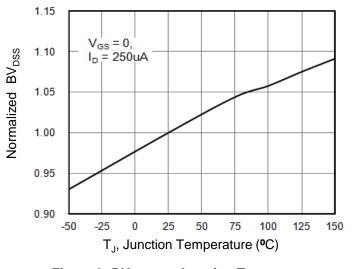


Figure 9: BV_{DSS} vs. Junction Temperature

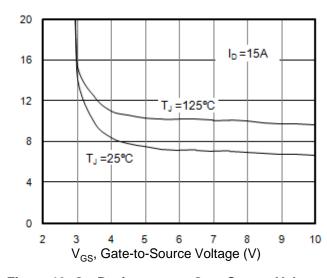


Figure 10: On-Resistance vs. Gate-Source Voltage

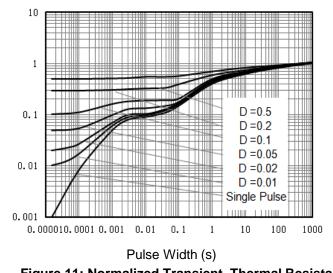


Figure 11: Normalized Transient Thermal Resistance

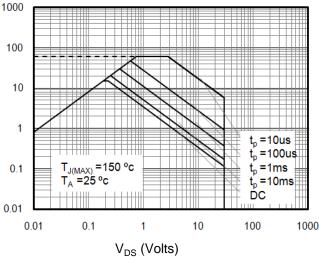


Figure 12: Safe Operating Area

 $R_{DS(on)}$ (m Ω)

l_D (Amps)



Figure A: Gate Charge Test Circuit and Waveforms

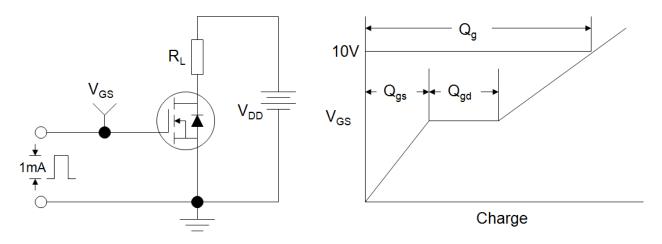


Figure B: Resistive Switching Test Circuit and Waveforms

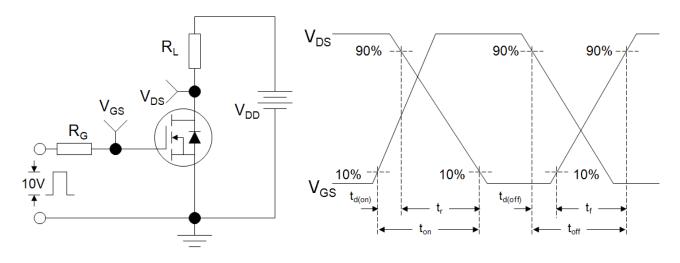
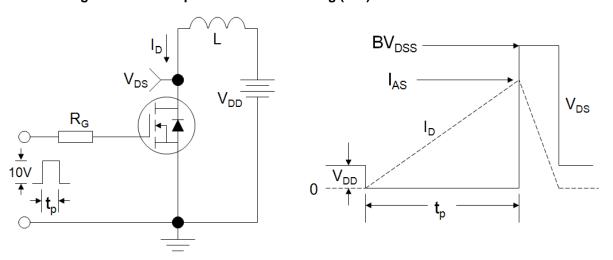
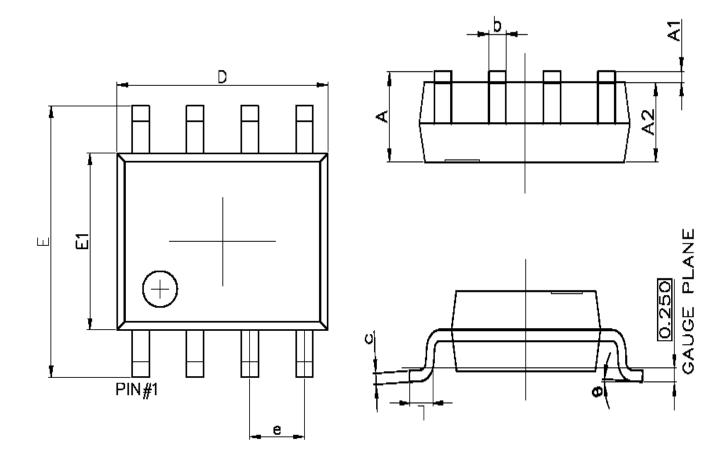


Figure C: Unclamped Inductive Switching (UIS) Test Circuit and Waveforms





SOP-8



Symbol	Dimensions In	n Millimeters	Dimensions In Inches		
Symbol	Min.	Max.	Min.	Max.	
Α	1.450	1.750	0.053	0.069	
A1	0.100	0.250	0.004	0.010	
A2	1.350	1.550	0.053	0.061	
b	0.330	0.510	0.013	0.020	
С	0.170	0.250	0.007	0.010	
D	4.700	5.100	0.185	0.201	
е	1.270 (BSC)	0.050(BSC)	
Е	5.800	6.200	0.228	0.244	
E1	3.800	4.000	0.150	0.157	
Ĺ	0.400	1.270	0.016	0.050	
θ	0°	8°	0°	8°	



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